

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. 248435US90CONT	SERIAL NO. NEW APPLICATION				
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Atsushi ISHIGE et al					
		FILING DATE HEREWITH					
		GROUP					
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
DSN	AP	WO 00/59722	10/12/00	JAPAN (English Abstract, only)		XXX	
DSN	AQ	59-198149	11/09/84	JAPAN (w/English Abstract)		XXX	
DSN	AR	8-333466	12/17/96	JAPAN (w/English Abstract)		XXX	
DSN	AS	0 845 490	06/03/98	EUROPE			
DSN	AT	0 666 183	08/09/95	EUROPE			
DSN	AU	0 501 441	09/02/92	EUROPE			
DSN	AV	0 862 991	09/09/98	EUROPE			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Patent Abstracts of Japan, JP 08-027294, January 30, 1996.					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner H. Sakuma					Date Considered 9/30/2004		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/ Applicant</u>
218248US0 CONT	10/061,224	02/04/02	ISHIGE
235952US90 CIP	10/400,866	03/28/03	ISHIGE, et al.
248435US90 CONT*	10/768,033	02/02/04	ISHIGE, et al.


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PRIMARY EXAMINER

*Present Application; listed for information
NFO/amr